

SPECIFICATIONS

TO MESSRS :

ITEM : LED Lamp MODEL : SP5-Z1501T/B-1

- Contents -

- Features
- Devices
- Package Dimensions
- Absolute Maximum Ratings
- Electro-optical Characteristics
- Characteristics Diagrams
- Model Number Description
- Packing & Description
- Solder Condition
- Precaution for Use
- Reliability Test

Drawn by	Checked by	Approved by



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SP5-Z1501□ SERIES PHOTO TRANSISTORS

Φ 5mm CYLINDER TYPE

SP5-Z1501T-1 SP5-Z1501B-1

PACKAGE DIMENSIONS

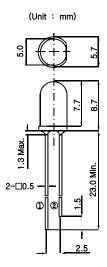
FEATURES

- Φ 5mm all epoxy resin mold type
- Cylinder type phototransistor
- ► Visible light cut-off type(SP5-Z1501B-1)

DEVICES

Model No.	Lens Type			
	Epoxy Color	Diffusion		
SP5-Z1501T-1	Water Clear	Transparency		
SP5-Z1501B-1*	¹ Black	Transparency		

*1 Visible light cut-off resin



Anode
Cathode

Unspecified Tolerance : $\pm \mbox{ 0.2mm}$

ABSOLUTE MAXIMUM RATINGS

(Ta = 25℃)

Parameter	Symbol	Value	Unit
Collector Power Dissipation	P _c	50	mW
Collector-emitter Voltage	V _{CEO}	30	V
Emitter-collector Voltage	V _{ECO}	5	V
Collector Current	۱ _с	20	mA
Operating Temperature	T _{opr}	- 30 to + 85	С
Storage Temperature	T _{stg}	- 40 to + 100	Ĵ
Soldering Temperature*2	T _{sol}	260(within 3 seconds)	Ĵ

*2 Soldering part of lead : up to 2mm from the body of the device



PHOTO TRANSISTORS SP5-Z1501T-1 SP5-Z1501B-1

■ ELECTRO-OPTICAL CHARACTERISTICS

(Ta=25 ℃)

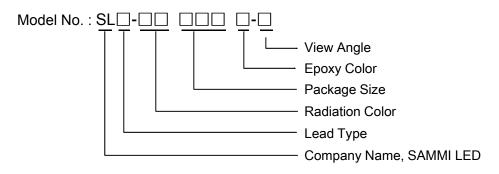
Parameter		Symbol	Min.	Тур.	Max.	Unit	Condition
Collector Current *3		Ι _C	330	600	1300	μA	V _{CE} =5V, Ee=0.52mW/cm ²
Collector Dark Current		I _{CEO}		2x10 ⁻³	0.1	μA	V _{CE} =10V, Ee=0
Collector-emitter Saturation Voltage*3		V _{CE} (sat)		0.2	0.4	V	I _C =0.5mA, Ee=10mW/cm ²
Intermediate Acceptance Angle		Θ1/2		±24		deg.	
Peak Sensitive Wavelength	SP5-Z1501T-1	λ _P		800		nm	
	SP5-Z1501B-1			860		11111	
Response Time(Rise/Fall)		t _r / t _f		15/15		μS	V_{CE} =5V, Ic=1mA, R _L =1k Ω

*3 Ee: Irradiance by CIE standard light source



LED LAMPS

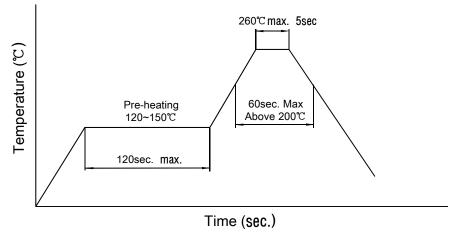
MODEL NUMBER DESCRIPTION



PACKING & DESCRIPTION

- 1. Inner packing : packing the vinyl pack unit at 500 pcs, and then packing inner paper box unit at 3 vinyl packs(1500 pcs)
- 2. Description on the paper box ① Model ②Lot No. ③ Quantity

SOLDER CONDITIONS



- 1. Preliminary heating to be at 150°C max. for 120sec max.
- 2. Soldering heat to be at 260°C max for 3sec.



LED LAMPS

PRECAUTION FOR USE

- 1. Avoid bending the Lead by constraint.
- 2. Do not soldering in condition with force to stress on the Lead.
- 3. Soldering flux does not contain chlorine elements against rust, and consider whether it need to be cleaning.
- 4. Avoid cleaning with the whole LED Lamp.
- 5. Use the methyl alcohol for cleaning the part of Flux soldering
 - Temperature : below 45 °C
 - Cleaning time : within 30 sec.
- 6. Use it within 1 week after the pack was opened.
- 7. Storage Instructions
 - 7-1. It is recommend to store the products in dried spot and avoid the low-temperature or high-temperature.
 - 7-2. It is recommend to avoid the spots with gas or winds affected with rust on Lead.
 - 7-3. It is recommend to avoid the direct rays of the sun.
 - 7-4. It is recommend to do not press or enforce to change quality and variation on products.
- 8. Static Electricity
 - 8-1. The LEDs static electricity and surge voltage damage. So it is recommended that a wrist band or anti-electro-static glove be used when handing the LEDs.
 - 8-2. All devices, equipment and machinery must be properly grounded. It is recommended that measures be taken against surge voltage to the equipment that mounts the LEDs.
 - 8-3. When inspecting the final products in which LEDs were assembled, it is recommended to check whether the assembled LEDs are damaged by static electricity or not. It is easy to find static-damaged LEDs by a light-on test or a VF test at a lower current.
- 9. Others
 - Regarding the detail or other questions, please contact Quality Control Management Department.



LED LAMPS

RELIABILITY TEST

1. Results of Reliability Test

Test Item	Test Condition	Note	Number of Damaged
Life Test	Ta=25°C, I _F =20mA	1000hrs	0/20
High Temperature Operating	Ta=85°C, I _F =5mA	1000hrs	0/20
Low Temperature Operating	Ta=-30°C, I _F =20mA	1000hrs	0/20
Thermal Shock	Ta= -30℃ ~ 85℃ 15sec 15sec	100 Cycle	0/20
High Temperature Storage	Ta=100°C	1000hrs	0/20
Low Temperature Storage	Ta=-40°C	1000hrs	0/20
Temperature Humidity Operating	Ta=85℃, RH=85%	1000hrs	0/20
Solder Heat	Ta= 260°C, 3sec.	1000hrs	0/20

2. Criteria for Judging the Damage

Item	Symbol	Task Qaraditian	Limit		
		Test Condition	Min.	Max.	
Forward Voltage	V _F	I _F =20mA		U.S.L×1.1	
Reverse Current	I _R	V _R =5V		U.S.L×2.0	
Luminous Intensity	lv	I _F =20mA	L.S.L×0.7		

Notes 1. U.S.L : Upper Standard Level 2. L.S.L : Lower Standard Level

